

Search Notes

Application/Control No.

10/740,698

Examiner

Benjamin Huh

Applicant(s)/Patent under
Reexamination

VARNER ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	890.1, 891.1, 93.01, 521	6/30/2006	BHH
424	427-428	6/30/2006	BHH
424	422	6/30/2006	BHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/30/2006	BHH